

0977659-020701

SPECIFICATION

TO ALL WHOM IT MAY CONCERN:

BE IT KNOWN THAT I, Kazuyuki Kanazashi, a citizen of Japan residing at Kawasaki, Japan have invented certain new and useful improvements in

DATA INPUT CIRCUIT AND SEMICONDUCTOR  
DEVICE UTILIZING DATA INPUT CIRCUIT

of which the following is a specification : -

TITLE OF THE INVENTION

DATA INPUT CIRCUIT AND SEMICONDUCTOR  
DEVICE UTILIZING DATA INPUT CIRCUIT

5 BACKGROUND OF THE INVENTION

1. Field of the Invention

The present invention relates to a data  
input circuit and a semiconductor device utilizing  
the data input circuit. The present invention more  
10 particularly relates to a data input circuit  
receiving serial data synchronously to a clock, and  
converting the serial data to parallel data, and a  
semiconductor device utilizing the data input  
circuit.

15 2. Description of the Related Art

Some semiconductor devices include an  
input circuit converting serial data supplied from  
outside the semiconductor devices to parallel data,  
and outputting the parallel data to a data bus by  
20 following an address signal. The input circuit  
creates a plurality of address signals from a single  
address signal supplied in accordance with a command  
signal, and outputs the parallel data to the data  
bus by following the plurality of address signals.

25 FIG. 1 is a diagram showing a  
configuration of a conventional input circuit. An  
input circuit 100 includes an input buffer 110, a  
shift register 120 (a data-acquiring buffer) and a  
data switch unit 130. The data switch unit 130  
30 includes switches 131 through 134. Additionally,  
FIGS. 2A and 2B are diagrams showing signal  
processes performed by the input circuit 100. It  
should be noted that FIGS. 1, 2A and 2B show a case  
in which data is supplied to the input circuit 100  
35 by a DDR (Double Data Rate) method supplying the  
data with a frequency twice as higher than that of  
an external clock, for instance.

An address signal A2 is initially supplied to the input circuit 100 with a data-write command as shown in FIG. 2A. The address signal A2 is one of address signals A0, A1, A2 and A3 expressed by a combination of the least two significant bits (Y1, Y0) of an address. Additionally, the address signal A2 supplied with the data-write command to the input circuit 100 indicates that input data is supplied to the input circuit 100 in order of data A2, data A3, data A0 and data A1 continuously after the address signal A2 and the data-write command have been supplied. To be concrete, the data A2, A3, A0 and A1 is supplied through the input buffer 110 to the shift register 120 in the order of the data A2, A3, A0 and A1 by following a frequency of an internal clock CLK1. The shift register 120 shifts data supplied thereto one by one as shown in FIG. 2B. For example, if an address signal supplied with the data-write command to the input circuit 100 is the address signal A2, the shift register 120 stores the data A2, A3, A0 and A1 respectively in areas N0, N1, N2 and N3 of the shift register 120.

The areas N0, N1, N2 and N3 of the shift register 120 are respectively connected to the switches 131, 132, 133 and 134 included in the data switch unit 130. The switches 131 through 134 are connected to data buses A0 through A3. The input circuit 100 outputs input data to a data bus corresponding to a supplied address signal by controlling the switches 131 through 134 by following the supplied address signal. For example, in the case in which an address signal supplied with the data-write command to the input circuit 100 is the address signal A2, the areas N0, N1, N2 and N3 are respectively connected with the data buses A2, A3, A0 and A1 as shown in FIG. 2B. As described above, the input circuit 100 creates a group of four

1. The first step is to identify the problem. This involves understanding the current situation and what needs to be changed.

1. The first step is to identify the problem. This involves understanding the current situation and what needs to be changed.

1. The first step is to identify the problem. This involves understanding the current situation and what needs to be changed.

1. The first step is to identify the problem. This involves understanding the current situation and what needs to be changed.

counter 150 generates data-acquiring clocks 1 through 4 by following the address signal A2 as shown in FIG. 4B, and supplies the data-acquiring clocks to the data-acquiring buffers 140 through 143.

5 To be concrete, the data-acquiring clocks 1, 2, 3 and 4 are respectively supplied to the data-acquiring buffers 140, 141, 142 and 143. The data-acquiring buffers 140 through 143 obtain the input data A0 through A3 respectively at rising edges of  
10 the data-acquiring clocks 1 through 4 as shown in FIG. 4C. Subsequently, the data-acquiring buffers 140 through 143 outputs obtained input data, for example, the input data A0 through A3 respectively to the data buses A0 through A3.

15 The input circuit 200 shown in FIG. 3 needs to generate the data-acquiring clocks at the highest frequency possible. However, since a logical circuit such as the address counter 150 must generate the data-acquiring clocks, speed up of  
20 processes executed by the input circuit 200 is hard.

#### SUMMARY OF THE INVENTION

Accordingly, it is a general object of the present invention to provide a data input circuit  
25 and a semiconductor device utilizing the data input circuit. A more particular object of the present invention is to provide a data input device speeding up its processing speed with a simplified circuit structure reducing a circuit size, and a  
30 semiconductor device utilizing the data input device, in which the disadvantages described above are eliminated.

The above-described object of the present invention is achieved by a data input circuit  
35 converting input serial data to n-bit parallel data,  
and outputting the n-bit parallel data by following  
an address signal, the data input circuit including

5 plurality of columns as an input column by following the address signal, wherein the input serial data is inputted to the data shifting unit through the input column.

```

10  input the input serial data to the data shifting
    unit. Subsequently, the data shifting unit obtains
    the input serial data, and shifts the input serial
    data so that the input serial data stored in each
    column of the data shifting unit can be outputted to
15  its corresponding destination.

```

Thus, the data input device can speed up its processing speed with a simplified circuit structure reducing a circuit size.

Other objects, features and advantages of  
20 the present invention will become more apparent from  
the following detailed description when read in  
conjunction with the accompanying drawings.

## BRIEF DESCRIPTION OF THE DRAWINGS

25               FIG. 1 is a diagram showing a  
configuration of a conventional input circuit;

FIGS. 2A and 2B are diagrams showing signal processes performed by the conventional input circuit;

30               FIG. 3 is a diagram showing a  
configuration of another conventional input circuit;

FIGS. 4A, 4B and 4C are diagrams showing signal processes performed by the conventional input circuit shown in FIG. 3;

35                   FIG. 5 is a diagram showing a  
configuration of an input circuit according to a  
first embodiment of the present invention;

FIGS. 6A and 6B are diagrams showing signal processes performed by the input circuit according to the first embodiment;

FIG. 7 is a diagram showing a  
5 configuration of a shift register, according to the first embodiment;

FIG. 8 is a diagram showing a configuration of the input circuit according to a second embodiment of the present invention;

10 FIGS. 9A and 9B are diagrams showing signal processes performed by the input circuit according to the second embodiment;

FIG. 10 is a diagram showing a configuration of the shift register, according to  
15 the second embodiment; and

FIG. 11 is a block diagram showing a configuration of a semiconductor device utilizing the input circuit according to the present invention.

20 DESCRIPTION OF THE PREFERRED EMBODIMENTS

A description will now be given of preferred embodiments of the present invention, with reference to the accompanying drawings.

FIG. 5 is a diagram showing a  
25 configuration of an input circuit 1 according to a first embodiment of the present invention. The input circuit 1 shown in FIG. 5 includes an input buffer 10, an input-point selector (a decoder) 12, a shift register (a data-acquiring buffer) 14,  
30 inverters 16 through 20, and NAND gates 21 through 23. The input circuit 1 (generates a plurality of address signals from a single address signal  
supplied in accordance with a command signal)  
35 converts serial data supplied from outside the input circuit 1 to parallel data, and outputs the parallel data to a data bus by following the plurality of address signals.

Address signals  
Input Data

5 A description will now be given of a case in which the input circuit 1 creates a group of four address signals, for example, address signals A0 through A3, each address signal corresponding to a combination of the least two significant bits of an address, automatically recognizes an order of four input data, and outputs the four input data to their corresponding data buses A0 through A3. The shift register 14 includes seven columns that are N3, N2, 10 N1, N0, N3', N2' and N1', and shifts input data from the column N3 toward the column N1'. If the input circuit 1 uses a group of  $2^n$  address signals in which a number "n" is a natural number, the shift register 14 includes  $2^{n+1}-1$  columns. The input-point 15 selector 12 controls a data input point of the shift register 14 by following an address signal inputted thereto. For example, the input-point selector 12 selects the column N1 as the data input point of the shift register 14 in a case in which the address 20 signal A2 is supplied to the input circuit 1 with a data-write command. The columns N3 and N3' of the shift register 14 are connected to the NAND gate 21 whose output terminal is connected to the data bus A3 through the inverter 16. Similarly, the columns 25 N2 and N2' of the shift register 14 are connected to the NAND gate 22 whose output terminal is connected to the data bus A2 through the inverter 17. The columns N1 and N1' of the shift register 14 are connected to the NAND gate 23 whose output terminal 30 is connected to the data bus A1 through the inverter 18. Additionally, the column N0 of the shift register 14 is connected to the data bus A0 through the inverters 20 and 19.

FIGS. 6A and 6B are diagrams showing 35 signal processes performed by the input circuit 1, according to the first embodiment. The address signal A2 is initially supplied with the data-write



5 The address signal A2, supplied with the data-write command indicates that the input data is supplied to  
the input circuit 1 in order of the input data A2,  
A3, A0 and A1 after the address signal A2 is  
supplied thereto. If the address signal A4 is  
10 supplied with the data-write command to the input  
circuit 1, the input data is supplied to the input  
circuit 1 in order of the input data A4, A0, A1 and  
A2 after the address signal A4 is supplied thereto.  
The input-point selector 12 selects the column N1 as  
15 a data input point of the shift register 14 by  
following the supplied address signal A2 as shown in  
FIG. 6A. Subsequently, the input data is supplied  
to the shift register 14 through the input buffer 10  
by following a frequency of an internal clock CLK1  
20 in the order of the input data A2, A3, A0 and A1.  
Since the input-point selector 12 selects the column  
N1 of the shift register 14 as the data input point,  
the input data supplied from the input buffer 10 is  
inputted to the column N1 continuously in the order  
25 of the input data A2, A3, A0 and A1. As a result,  
the columns N1, N0, N3' and N2' store respectively  
the input data A1, A0, A3 and A2 as shown in FIG. 6B.  
The columns N1', N2 and N3 not storing the input  
data store a predetermined value, for example, a  
30 high-level signal or value as shown in FIG. 6B.

The input data A0 stored in the column N0 of the shift register 14 is outputted to the data bus A0 through the inverters 20 and 19. The input data A1 stored in the column N1 of the shift register 14 and a value stored in the column N1' of the shifter register 14 are supplied to the NAND gate 23, whose output is outputted to the data bus

Where you  
 feed data  
 into the Shift  
 register from:  
 If  $N_0$ , put it  
 in  $N_0, N_3, N_2, N_1$  20  
 In other words,  
 Starting with  $N_1$  25  
 feed in the values  
 continuously After  $N_1$ .

Net  
Through NH-

Now I  
They have  
All been  
stupid!  
feed the  
values out!

A1 through the inverter 18. Similarly, the input data A2 stored in the column N2' of the shift register 14 and a value stored in the column N2 of the shifter register 14 are supplied to the NAND gate 22, whose output is outputted to the data bus A2 through the inverter 17. The input data A3 stored in the column N3' of the shift register 14 and a value stored in the column N3 of the shifter register 14 are supplied to the NAND gate 21, whose output is outputted to the data bus A3 through the inverter 16. For instance, the values stored in the columns N1', N2 and N3 are high-level signals, the input data A1 stored in the column N1, the input data A2 stored in the column N2' and the input data A3 stored in the column N3' are outputted to the data bus A1, A2 and A3 respectively.

FIG. 7 is a diagram showing a configuration of the shift register 14, according to the first embodiment. The shift register 14 shown in FIG. 7 includes switches SW0 through SW3, flip-flops FF0 through FF3 and FF1' through FF3', inverters 30 through 33, and NOR gates 34 through 37. The input-point selector 12 outputs a signal selecting the column N1 of the shift register 14 to the shift register 14 by following the address signal A2 after receiving the address signal A2 and the data-write command as shown in FIG. 6A. To be concrete, the input-point selector 12 outputs a high-level signal from its output terminal N(A2) to the switch SW2 of the shift register 14, and low-level signals from the other terminals N(A0), N(A1) and N(A3) respectively to the switches SW0, SW1 and SW3. The switch SW2 connects to a side "b" after receiving the high-level signal from the output terminal N(A2) of the input-point selector 12. Each of the switches SW0 and SW3 connects to a side "a" after receiving the low-level signal respectively

Object

Consequently, the input data A2, A3, A0 and A1 is inputted continuously to the flip-flop FF1 of the shift register 14 through the switch SW2 connected to the side "b", and is shifted one after another toward the flip-flop FF1'. Because of shifting the input data, the shift register 14 stores the input data A1, A0, A3 and A2 respectively in the flip-flops FF1, FF0, FF3' and FF2'. Additionally, the shift register 14 is configured so as to supply a SET signal to the flip-flops FF3, FF2 and FF1', which do not store the input data. When a high-level SET signal is supplied, a flip-flop outputs a high-level signal from its output terminal Q.

Additionally, the input circuit 1 includes  $2n-1$  columns in the shift register 14 in order to generate  $n$ -bit parallel data and selecting the data input point among the  $2n-1$  columns, thereby enabling conversion of supplied serial data to the  $n$ -bit parallel data and output of the  $n$ -bit parallel data to its corresponding data bus or the like. In the case of including the  $2n-1$  columns in the shift register 14, columns not storing the supplied serial data are also included in the shift register 14. Thus, the input circuit 1 can obtain the  $n$ -bit

parallel data by executing a logical arithmetic operation on a combination of data outputted from the columns not storing the supplied serial data and from the columns storing the supplied serial data.

5                   FIG. 8 is a diagram showing a configuration of an input circuit 2 according to a second embodiment of the present invention. The input circuit 2 shown in FIG. 8 includes the input buffer 10, the input-point selector 12, a shift  
10 register 40, and inverters 42 through 49. A unit shown in FIG. 8 having the same unit number as a unit shown in FIG. 5 is equivalent to the unit shown in FIG. 5. The shift register 40 includes four columns N3, N2, N1 and N0, and shifts input data in  
15 a direction from the column N3 to the column N0. Additionally, the shift register 40 is provided with a feedback loop so that input data shifted to the column N0 is fed back to the column N3 at the next shift. The shift register 40 needs to have  $2^n$   
20 columns in which a number "n" is a natural number if a group of  $2^n$  address signals is provided thereto. The input-point selector 12 controls a data input point of the shift register 40 by following an address signal inputted thereto similarly to the  
25 shift register 14 described in the first embodiment. The column N3 of the shift register 40 is connected to the data bus A3 through the inverters 46 and 42. Similarly, the column N2 of the shift register 40 is connected to the data bus A2 through the inverters  
30 47 and 43. The column N1 of the shift register 40 is connected to the data bus A1 through the inverters 48 and 44. The column N0 of the shift register 40 is connected to the data bus A0 through the inverters 49 and 45. The shift register 40 thus  
35 outputs input data stored in the columns N0 through N3 to the data buses A0 through A3 respectively.

FIGS. 9A and 9B are diagrams showing

signal processes performed by the input circuit 2, according to the second embodiment. The address signal A2 and the data-write command are supplied to the input circuit 2 as shown in FIG. 9A. The input-point selector 12 selects the column N1 as a data input point of the shift register 40 as shown in FIG. 9A. Subsequently, the input data is supplied to the shift register 40 through the input buffer 10 by following the frequency of the internal clock CLK1 in order of the input data A2, A3, A0 and A1. Since the input-point selector 12 selects the column N1 of the shift register 40 as the data input point of the shift register 40, the input data A2, A3, A0 and A1 is continuously inputted to the shift register 40 from the column N1. The input data A2 initially enters the column N1, and is stored in the column N1. At the next step, the input data A3 enters the column N1, and is stored in the column N1. Meanwhile, the input data A2 is shifted to the column N0, and is stored in the column N0. Subsequently, at the time the input data A0 is entering the column N1, the input data A3 is shifted to the column N0 as well as the input data A2 is fed back to the column N3. Thus, after the input data A2, A3, A0 and A1 is inputted from the column N1 to the shift register 40 one by one, the shift register 40 stores the input data A3, A2, A1 and A0 respectively in the columns N3, N2, N1 and N0. Subsequently, the input data A3, A2, A1 and A0 stored respectively in the columns N3, N2, N1 and N0 of the shift register 40 is outputted respectively to the data buses A3, A2, A1 and A0 through two inverters.

FIG. 10 is a diagram showing a configuration of the shift register 40, according to the second embodiment. The shift register 40 shown in FIG. 10 includes switches SW0 through SW3, and

20                    Accordingly, the input data supplied from  
the input buffer 10 is inputted to the flip-flop FF1  
through the switch SW2 connected to the side "b".  
Subsequently, the input data A2, A3, A0 and A1  
inputted to the shift register 40 from the flip-flop  
25 FF1 is shifted in order through the switches SW1,  
SW0 and SW3, which are connected to the sides "a".  
Input data stored in the flip-flop FF0 is shifted  
when new input data is inputted to the flip-flop FF1.

As described above, the shift register 40  
30 can select a data input point by following an  
address signal supplied with the data-write command,  
and can output supplied input data to their  
corresponding data buses. Additionally, the input  
circuit 2 according to the second embodiment stores  
35 input data in all the flip-flops provided in the  
shift register 40, and thus does not have to provide  
a SET signal necessary in the first embodiment to the

shift register 40, thereby achieving objects of the present invention with a simpler circuit structure.

Additionally, the input circuit 2 includes a feed-back loop in the shift register 40, and thus does not need to include no more than n columns in the shift register 40 for generating n-bit parallel data.

According to the first and second embodiments, the shift registers 14 and 40 include a plurality of switches and flip-flops, thereby enabling input of serial data to the shift registers 14 and 40 through the plurality of flip-flops.

FIG. 11 is a block diagram showing a configuration of a semiconductor device 3 utilizing the input circuit 1 or 2 according to the present invention. The semiconductor device 3 shown in FIG. 11 is a SDRAM (Synchronous Dynamic Random Access Memory) utilizing a delayed-write method and the input circuit 1 or 2 according to the present invention. Data inputted to the semiconductor device 3 is supplied to a serial-parallel converter 52 through a buffer/register 50, the serial-parallel converter 52 corresponding to the input circuit 1 or 2. The serial-parallel converter 52 can generate a plurality of address signals from a single address signal supplied in accordance with a command signal, can convert serial data to parallel data, and can output the parallel data to a common data bus. It should be noted that the single address signal necessary for processes performed by the present invention is supplied to the serial-parallel converter 52.

Thus, by applying the input circuit 1 or 2 to the semiconductor device 3, the semiconductor device 3 can reduce its circuit size, and can convert supplied serial data to parallel data speedily as well as can output the parallel data to

a data bus.

As describe above, the present invention provides a method of converting serial data to parallel data by inputting the serial data to a data shifting method from a column of the data shifting method determined by use of an address signal, and outputting the parallel data to its corresponding data bus. Therefore, the present invention can provide a data input device speeding up its processing speed with a simplified circuit structure whose circuit size is reduced, and a semiconductor device utilizing the data input device.

The above description is provided in order to enable any person skilled in the art to make and use the invention and sets forth the best mode contemplated by the inventors of carrying out the invention.

The present invention is not limited to the specially disclosed embodiments and variations, and modifications may be made without departing from the scope and spirit of the invention.

The present application is based on Japanese Priority Application No. 2000-030803, filed on February 8, 2000, the entire contents of which are hereby incorporated by reference.

0977899.020704